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# AO3415

# 20V P-Channel MOSFET

# **General Description**

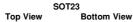
The AO3415 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch applications.

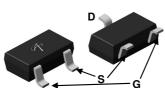
# **Product Summary**

 $\begin{array}{lll} V_{DS} & -20V \\ I_{D} \; (at \; V_{GS} \!\!=\! \!\! -4.5V) & -4A \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -4.5V) & < 41 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -2.5V) & < 53 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -1.8V) & < 65 m\Omega \end{array}$ 

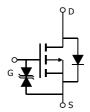
ESD protected







Junction and Storage Temperature Range



-55 to 150

Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V <sub>DS</sub>	-20	V			
Gate-Source Voltage		V <sub>GS</sub>	±8	V			
Continuous Drain	T <sub>A</sub> =25℃		-4				
Current	T <sub>A</sub> =70℃	'D	-3.5	A			
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	-30				
	T <sub>A</sub> =25℃	D	1.5	W			
Power Dissipation <sup>B</sup>	T <sub>A</sub> =70℃	P <sub>D</sub>	1	vv			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	65	80	€/M			
Maximum Junction-to-Ambient AD	Steady-State $R_{\theta JA}$		85	100	€/M			
Maximum Junction-to-Lead Steady		$R_{\theta JL}$	43	52	€\M			

 $T_J, T_{STG}$ 



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V			-1	μА				
	2010 Gate Voltage Drain Garrent	T <sub>J</sub> =55℃			-5	μιτ				
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±8V			±10	μΑ				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	-0.3	-0.57	-0.9	V				
$I_{D(ON)}$	On state drain current	$V_{GS}$ =-4.5V, $V_{DS}$ =-5V	-30			Α				
R <sub>DS(ON)</sub>		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A		34	41	mΩ				
		T <sub>J</sub> =125℃		49	59	11122				
	Static Drain-Source On-Resistance	$V_{GS}$ =-2.5V, $I_D$ =-4A		42	53	mΩ				
		$V_{GS}$ =-1.8V, $I_D$ =-2A		52	65	mΩ				
		$V_{GS}$ =-1.5V, $I_D$ =-1A		61		mΩ				
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =-5V, $I_{D}$ =-4A		20		S				
$V_{SD}$	Diode Forward Voltage	Diode Forward Voltage I <sub>S</sub> =-1A,V <sub>GS</sub> =0V		-0.64	-1	V				
Is	Maximum Body-Diode Continuous Curr			-2	Α					
DYNAMIC	PARAMETERS									
C <sub>iss</sub>	Input Capacitance		600	751	905	pF				
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =-10V, f=1MHz	80	115	150	pF				
C <sub>rss</sub>	Reverse Transfer Capacitance		48	80	115	pF				
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz	6	13	20	Ω				
SWITCHI	NG PARAMETERS									
$Q_g$	Total Gate Charge		7.4	9.3	11	nC				
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =-4.5V, $V_{DS}$ =-10V, $I_{D}$ =-4A	8.0	1	1.2	nC				
$Q_{gd}$	Gate Drain Charge	]	1.3	2.2	3.1	nC				
t <sub>D(on)</sub>	Turn-On DelayTime			13		ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =-4.5V, $V_{DS}$ =-10V, $R_L$ =2.5 $\Omega$ ,		9		ns				
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		19		ns				
t <sub>f</sub>	Turn-Off Fall Time			29		ns				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-4A, dI/dt=500A/μs	20	26	32	ns				
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge I <sub>F</sub> =-4A, dI/dt=500A/μs		40	51	62	nC				

A. The value of  $R_{\text{BJA}}$  is measured with the device mounted on  $1 \text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using  $\leq$  10s junction-to-ambient thermal resistance. C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep institute.

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initial $T_J$ =25° C.

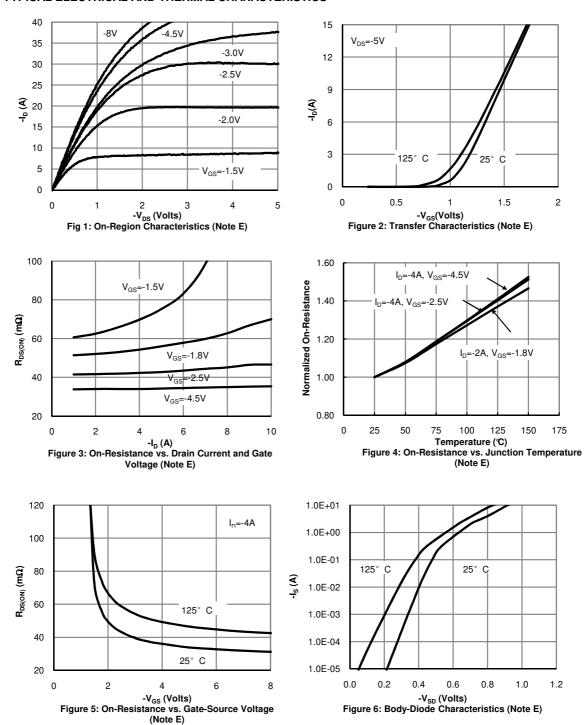
D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ$  C. The SOA curve provides a single pulse rating.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



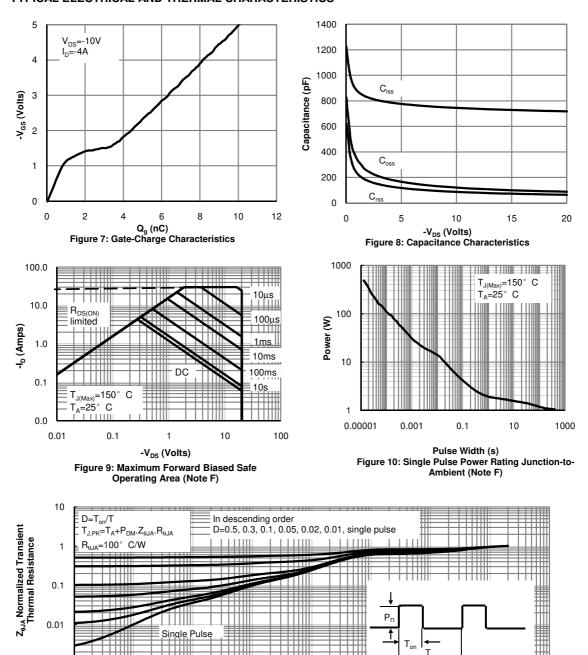


0.0001

0.0001

0.001

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

10

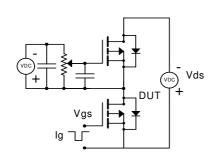
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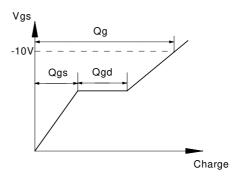
1000

0.01

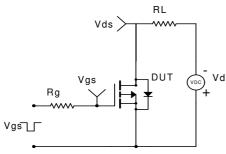


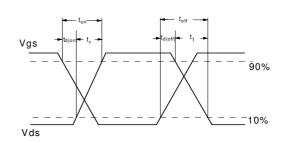
# Gate Charge Test Circuit & Waveform





# Resistive Switching Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

